Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/811,621	SHIH ET AL.	
Examiner	Art Unit	
Edna Wong	1753	

SEARCHED					
Class	Subclass	Date	Examiner		
106	1.26	1/18/2006	EW		
205	261	1/18/2006	EW		
205	296	1/18/2006	EW		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor Search	1/18/2006	EW	
EAST	1/18/2006	EW	
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